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		SPECIFICATION	REPRESENTATIVE DIVISION	☐ PHOTOVOLTAICS DIV. ☒ OPTO-ELECTRONIC DEVICES DIV. ☐ ELECTRONIC COMPONENTS DIV.

DEVICE SPECIFICATION FOR

PHOTOINTERRUPTER

MODEL No.

GP2S27T SERIES

Business dealing name

	GP2S27T
	GP2S27T2
	GP2S27T3
	GP2S27T5
	GP2S27T6

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2. Please obey the instructions mentioned below for actual use of this device.

(1) This device is designed for general electronic equipment.
Main uses of this device are as follows;

[·Computer ·OA equipment ·Telecommunication equipment (Terminal)
·Measuring equipment ·Tooling machine ·AV equipment
·Home appliance, etc.]

(2) Please take proper steps in order to maintain reliability and safety, in case this device is used for the uses mentioned below which require high reliability.

[·Unit concerning control and safety of a vehicle (air plane, train, automobile etc.) ·Gas leak detection breaker ·Traffic signal
·Fire box and burglar alarm box ·Other safety equipment, etc.]

(3) Please don't use for the uses mentioned below which require extremely high reliability

[·Space equipment ·Telecommunication equipment (Trunk)
·Nuclear control equipment ·Medical equipment (relating to any fatal element), etc.]

☐CUSTOMER'S APPROVAL

DATE

BY

PRESENTED BY K. Ebina

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Department General Manager of
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1. Application

This specification applies to the outline and characteristics of reflective type photointerrupter, Model No. GP2S27T series.

2. Outline

Refer to the attached drawing No. CY4607i02.

3. Ratings and characteristics

3.1 Absolute maximum ratings

Ta=25°C

Parameter		Symbol	Rating	Unit
Input	Forward current	I_F	50	mA
	Reverse voltage	V_R	6	V
	Power dissipation	P_D	75	mW
Output	Collector-emitter voltage	V_{CEO}	35	V
	Emitter-collector voltage	V_{ECO}	6	V
	Collector current	Ic	20	mA
	Collector power dissipation	Pc	75	mW
Total power dissipation		Ptot	100	mW
Operating temperature		Topr	-25 ∿ +85	°C
Storage temperature		Tstg	-40 ∿ +100	°C

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3.2 Electro-optical characteristics

Ta=25°C

Parameter			Symbol	MIN.	TYP.	MAX.	Unit	Conditions
Input	Forward voltage		V_F	-	1.2	1.4	V	I_F=20mA
	Reverse current		I_R	-	-	10	μA	V_R=6V
Output	Collector dark current		I_{CEO}	-	1	100	nA	V_{CE}=20V
Transfer characteristics	*1 Collector current		Ic	20	45	120	μA	V_{CE}=2V, I_F=4mA
	*2 Leak current		I_{LEAK}	-	-	100	nA	V_{CE}=2V, I_F=4mA
	*3 Response time	(Rise)	tr	-	20	100	μs	V_{CE}=2V, Ic=100μA
		(Fall)	tf	-	20	100	μs	R_L=1000Ω, d=1mm

*1 The conditions and arrangement of the reflective object are shown below.

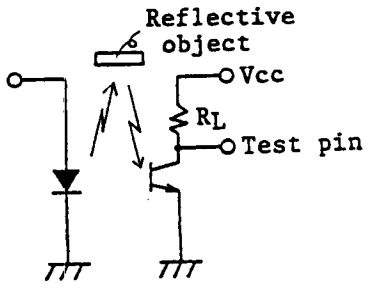
In regard to collector current (Ic), the following ranking shall be carried out.

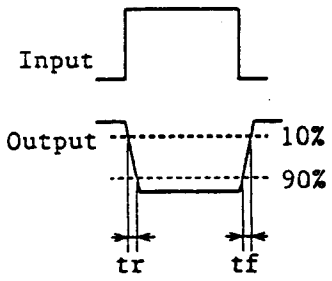
Rank	Collector current Ic(μA)
A	20 ∿ 42
B	34 ∿ 71
C	58 ∿ 120

*2 Without reflective object

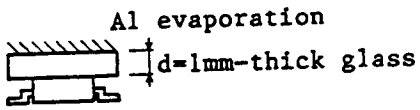
*3 d: Glass thickness of reflective mirror

(Test circuit for response time)





(Test arrangement for collector current)



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4. Reliability

Refer to the attached sheet, Page 7, 8.

5. Incoming inspection

Refer to the attached sheet, Page 9.

6. Supplements

6.1 Device delivery shall be delivered model that has "○" marking in the rank table below. However, in case delivered model has 2 ranks or more, the quantity of each rank shall be not prescribed.

Collector current (Ic) rank table

Rank at delivery	Model No.	Ic (μA)	Rank
	GP2S27T	20 ∿ 120	A, B or C
	GP2S27T2	34 ∿ 71	B
	GP2S27T3	58 ∿ 120	C
	GP2S27T5	20 ∿ 71	A or B
	GP2S27T6	34 ∿ 120	B or C

Test conditions
V_{CE}=2V
I_F=4mA
Ta=25°C

6.2 Parts

Refer to the attached sheet, Page 10.

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7. Notes

1) In circuit designing, make allowance for the degradation of the light emitting diode output that results from long continuous operation. (MAX.: 50% degradation/5 years)

2) To prevent photointerrupter from faulty operation caused by external light, do not set the detecting surface face to the external light.

3) The distance between the photointerrupter and the object to be detected shall be determined the distance by referencing attached graph "Relative collector current vs. distance".

4) Soldering

(1) Solder reflow

Please do only one soldering at the temperature and the time within the temperature profile in page 12.

(2) Soldering by hand

To solder onto lead pins, please solder at 260°C for 3 seconds or less. And please take care not to let any external force exert on lead pins when soldering.

5) Cleaning shall carry out as the below items to avoid keeping solvent, solder and flux on the device.

(1) Solvent cleaning: Solvent temperature 45°C or less
Immersion 3 min. or less

(2) Ultrasonic cleaning: Please don't carry out ultrasonic cleaning.

(3) The cleaning shall be carried out with solvent below.

Solvent: Ethyl alcohol, Methyl alcohol, Freon TE·TF
Daiflon-solvent S3-E

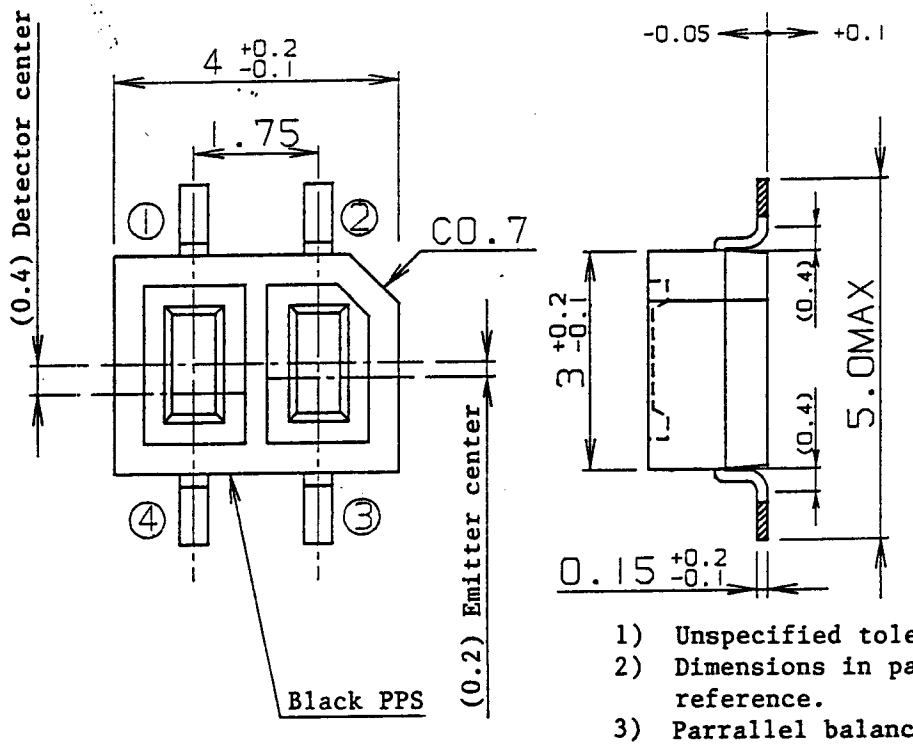
(4) Please refrain from using Chloro Fluoro Carbon type solvent to clean devices as much as possible since it is internationally restricted to protect the ozonosphere. Before you use alternative solvent you are requested to confirm that it does not damage package resin.

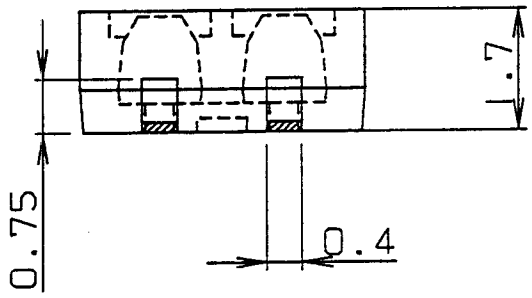
8. Others

Any doubt as to this specification shall be determined in good faith upon mutual consultation of the both parties.

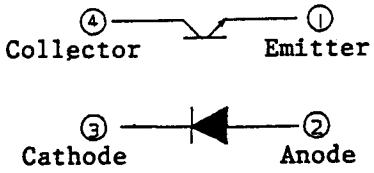
2. Outline Dimensions (Drawing No. CY4607i02)

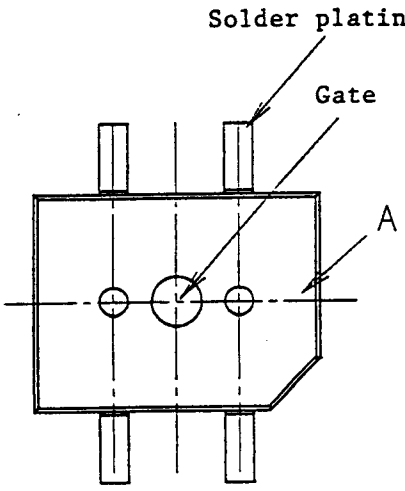
Scale : 10/1 Unit : 1/1mm



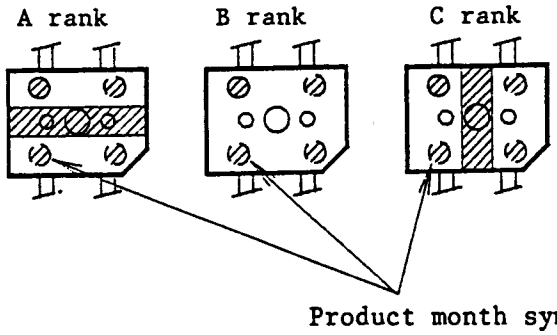


1) Unspecified tolerance shall be ±0.15.
2) Dimensions in parenthesis are shown for reference.
3) Parrallel balance of 4 lead pins shall be within ±0.15.
4) The dimensions shown do not include those of burrs. Burr's dimensions shall be 0.15 MAX..
5) Internal connection diagram is shown below.



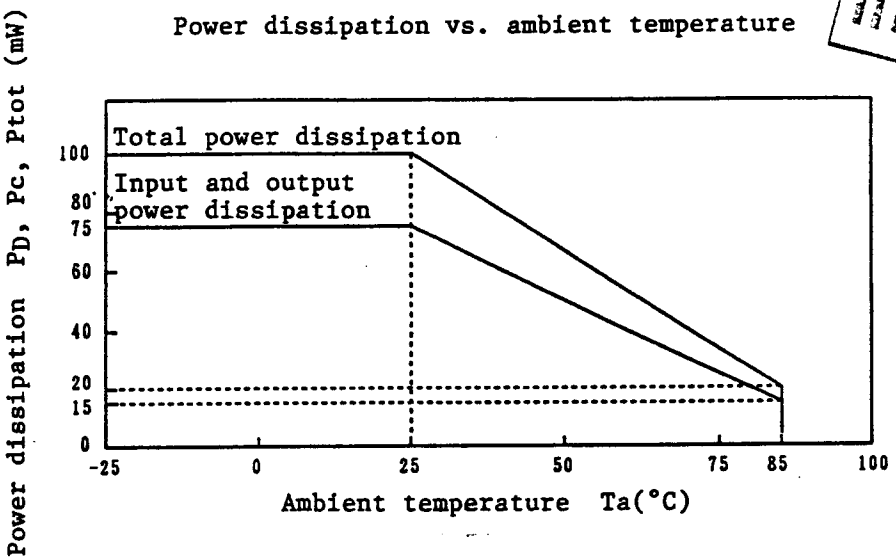


6) Marked face shall be surface A. The symbols of rank mark and production month is as follows.

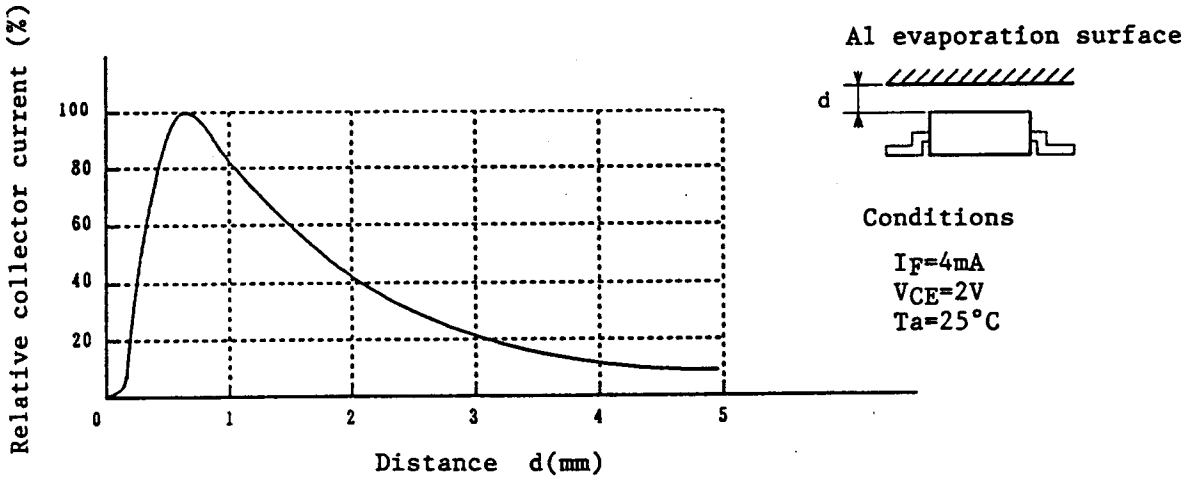


7) The oblique portions are no solder plating area.

Power dissipation vs. ambient temperature



Relative collector current vs. distance (reference)



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4. Reliability

The reliability of products shall be satisfied with items listed below.

Confidence level : 90%
LTPD : 10%/20%

Test Items	Test Conditions	Failue Judgement Criteria	Samples (n) / Defective(c)
Temperature cycling	1 cycle −40°C ∿ +100°C (30min.) (30min.) 20 cycle test	$V_F \geq U \times 1.2$ $Ic \leq L \times 0.8$ $I_{LEAK} \geq U \times 2$ $I_R \geq U \times 2$ $I_{CEO} \geq U \times 2$ U: Upper specificaiton limit L: Lower specification limit	n=22, c=0
Humidity storage	+60°C, 90%RH, 500h		n=22, c=0
High temp. storage	+100°C, 500h		n=22, c=0
Low temp. storage	−40°C, 500h		n=22, c=0
Operation life	I_F=50mA, Ta=25°C, 500h Ptot=100mW		n=22, c=0
Mechanical shock	15000m/s^2{1500G}, 0.5ms, 3 times/±X, ±Y, ±Z direction		n=11, c=0
Variable frequency vibration	100 ∿ 2000 ∿ 100 Hz/20min. 2h/X,Y,Z direction 100m/s^2{10G}		n=11, c=0
Terminal strength (Tension)	Weight: 3N{0.3kgf} 30 s/each terminal		n=11, c=0
Terminal strength (Bending)	Weight: 1N{0.1kgf} 0°→90°→0° 2 times bending		n=11, c=0
Soldering heat	260°C, 3s Immerse up to 0.5mm from the bottom face of package.		n=11, c=0
Solderability	230°C, 3 s Prior disposition: Dip rogin flux. Then immerse up to 0.5mm from the bottom face of package.	Judgement only appearance Solder shall adhere at the aera of 95% or more of dipped portion	n=11, c=0

For details, conforms to JIS C 7021.

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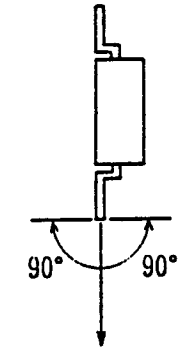
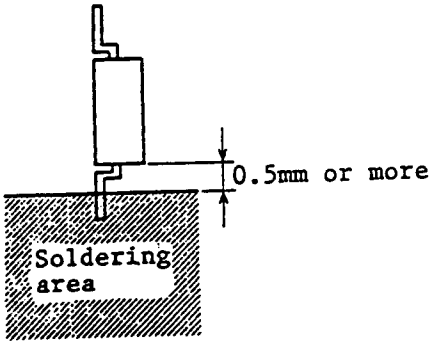


Weight: 1.0N{0.1kgf}



4.1 Solder reflow

Confidence level : 90%
LTPD : 10%/ 20%

Test Item	Test condition	Failure Judgement Criteria	Samples (n) / Defective(c)
Solder reflow	Refer to the attached sheet, Page 12. 1 time	Ic < L × 0.8	n=22, c=0

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5. Incoming inspection

5.1 Inspection items

(1) Electrical characteristics

V_F, I_R, BV_{ECO}, BV_{CEO}, Ic, I_{CEO}

(2) Appearance

5.2 Sampling method and Inspection level

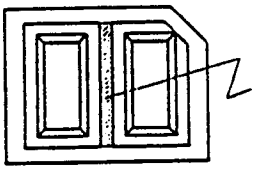
A single sampling plan, normal inspection level II based on MIL-STD-105D is applied. The AQL according to the inspection items are shown below.

Defect	Inspection item	AQL(%)
Major defect	Characteristics defect Unreadable marking	0.1
Minor defect	Appearance defect except the above mensioned. *	0.4

* Crack ..... Visible crack shall be defect.

* Split
Chip
Scratch
The others ..... One which affects the electrical characteristics shall be defect.

* Void ..... One which is void across central separator on photo sensor shall be defect.



Central separator

The other place voids, one which affects the electrical characteristics shall be defect.

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6. Supplements

6.1 Parts

This product uses the below parts.

6.1.1 Light detector

Type	Material	Maximum sensitivity wavelength (nm)	Sensitivity wavelength (nm)	Response time (μs)
Phototran-sistor	Silicon (Si)	800	700 ∿ 1200	20

6.1.2 Light emitter

Type	Material	Maximum light emitting wavelength (nm)	I/O Frequency (MHz)
Infrared light emitting diode (non-coherent)	GaAs	950	0.3

6.1.3 Material

Case	Lead frame	Lead frame plating
Black PPS resin	42 Alloy	Solder plating

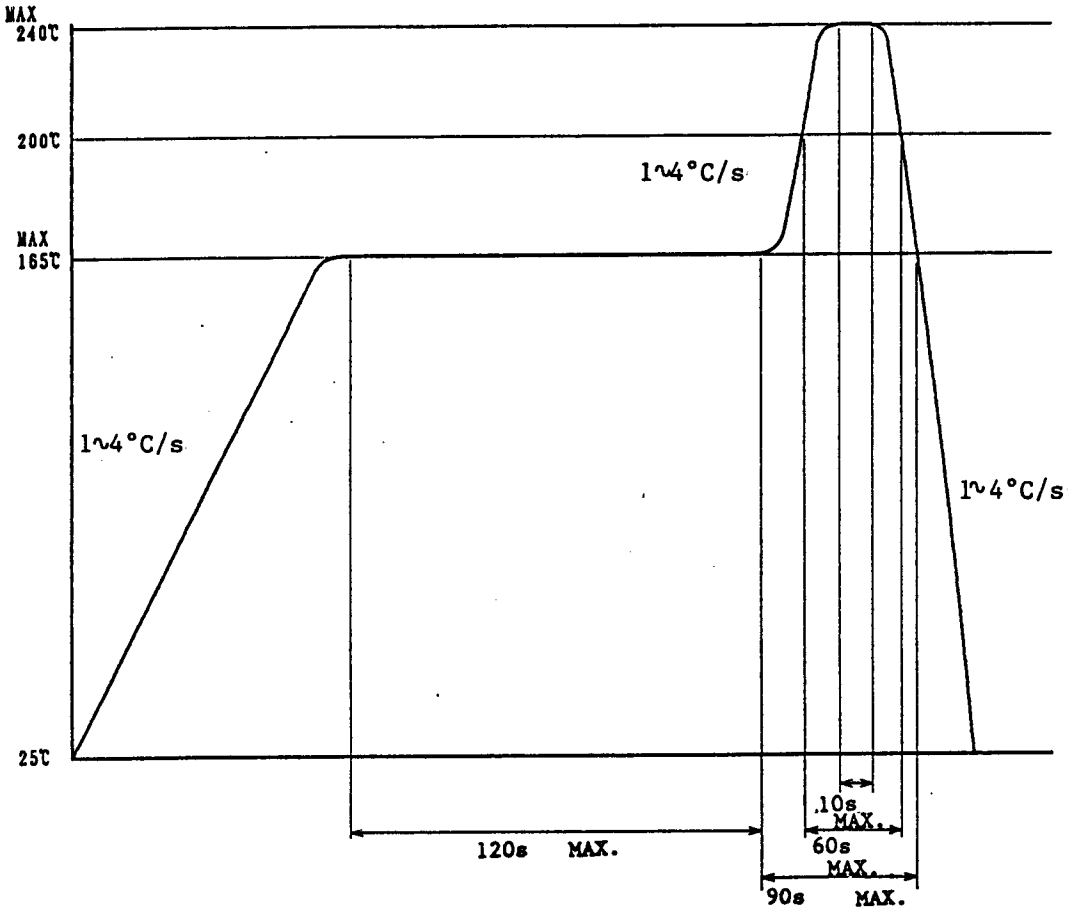
6.1.4 Others

This product shall not be proof against radiation flux.

Precautions for Soldering photointerrupter

1. In case, solder reflow

   Please do only one soldering at the temperature and the time within the temperature profile as shown in the figure.



2. Other precautions

   An infrared lamp used to heat up for soldering may cause a localized temperature rise in the resin. So keep the package temperature within that specified in Item 1. Also avoid immersing the resin part in the solder. Even if within the temperature profile above, there is the possibility that the gold wire in package is broken in case that the deformation of PWB gives the affection to lead pins. Please use after confirmation the conditions fully by actual solder reflow machine.

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Package specifications (ϕ178mm reel)

1. Application

This specification applies to the taping specifications and the relation items for the GP2S27T series.

2. Taping method

(2.1) Tape structure and Dimensions (Refer to the attached sheet-2-2)

The tape shall have a structure in which a cover tape is sealed heat-pressed on the carrier tape of hard vinyl-chloride to protect against static electricity.

(2.2) Reel structure and Dimensions (Refer to the attached sheet-2-3)

The taping reel shall be corrugated cardboard-made with its dimensions as shown in the attached drawing.

(2.3) Direction of product insertion (Refer to the attached sheet-2-3)

Product direction in carrier tape shall direct to the anode mark at the hole side on the tape.

3. Adhesiveness of cover tape

The exfoliation force between carrier tape and cover tape shall be 0.2N{0.02kgf} to 1N{0.1kgf} for the angle from 160° to 180°.

4. Rolling method and quanfity

Wind the tape back on the reel so that the cover tape will be outside the tape. Attach more than 20cm of blank tape to the trailer and the leader of the tape and fix the both ends with adhesive tape. One reel shall contain 1000 pcs.

5. Marking

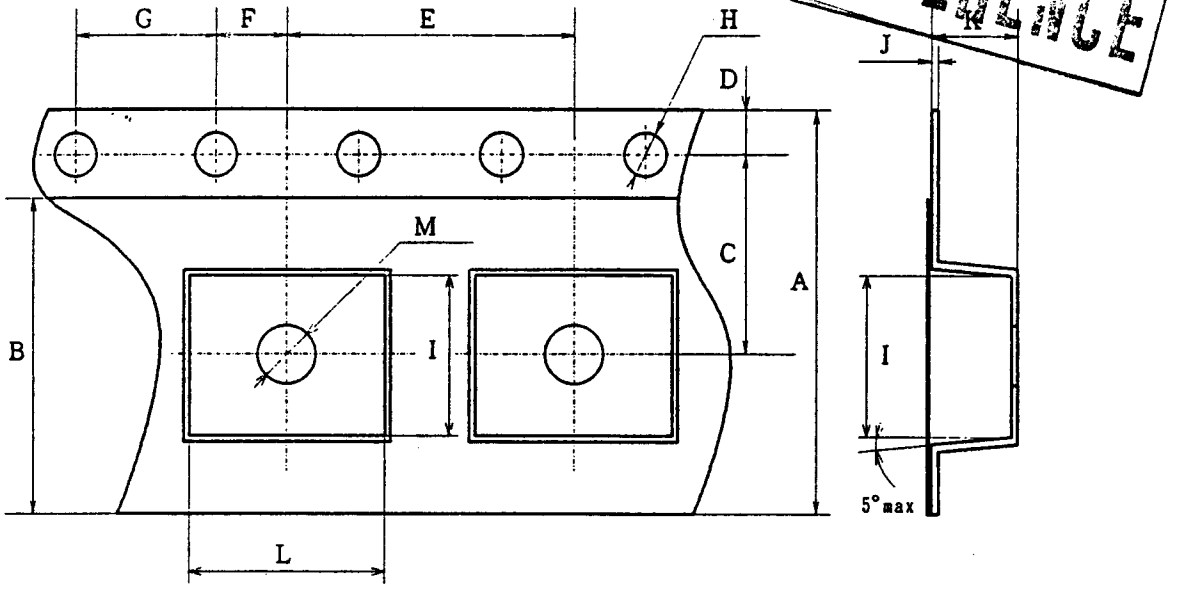
The outer packaging case shall be marked with following information.

* Model No. * Number of pieces delivered * Production date

6. Safety protection during shipping

There shall be no deformation of component or degradation of electrical characteristecs due to shipping.

Tape structure and Dimensions

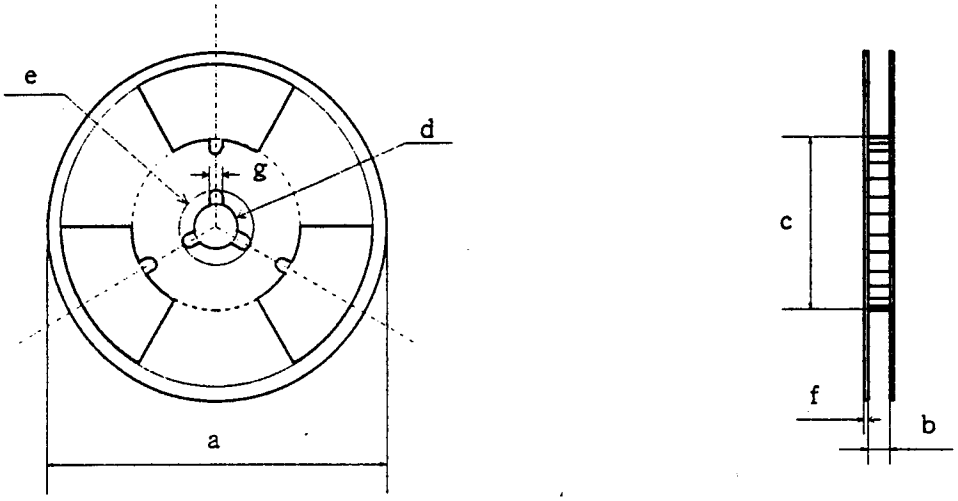


Symbol / Unit	A	B	C	D	E	F
mm	12.0 ±0.3	7.6 ± 0.3 0.0	5.5 ±0.05	1.75 ±0.1	8.0 ±0.1	2.0 ±0.05

Symbol / Unit	G	H	I	J	K	L	M
mm	4.0 ±0.1	φ1.5 ± 0.1 0.0	4.4 ±0.1	0.3 ±0.05	2.0 ±0.1	5.2 ±0.1	φ1.6 ± 0.1 0

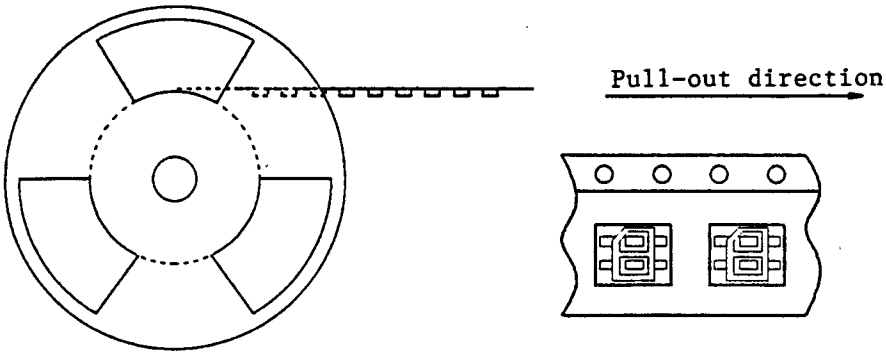
REFERENCE

Reel structure and Dimensions



Symbol / Unit	Check word						
	a	b	c	d	e	f	g
mm	178	13.5±1	80±0.1	13±0.5	23±1	2.0±0.5	2.5±0.5

Direction of product insertion



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REFERENCE

Moisture-proof package specification (ϕ178mm reel)

1. Application

This specification applies to the products which Sharp delivers to customer.

2. Packaging specifications

2.1 Packaging material

Name	Marerial	Q'ty	Aim
Aluminium laminated sack	Aluminium polyethylene	Refer to 2.2	Moisture-proof
Label	Paper(-made)	-	Indication of Model No. and Q'ty

2.2 Packaging method

(1) Seal the aluminium laminated sack included the ruled tape-reel quanfity.

(2) Fill up the blank of label and paste on the sack.

(3) Put the moisture-proof laminated sack in the ruled case.

Packaging shape	Product	Q'ty	Moisture-proof sack Q'ty
Tape-reel(ϕ178mm)	1ch. type	1000 pcs./reel	1reel/sack

Minimum order Q'ty : 1 reel/sack

3. Strage and management after open

3.1 Storage condition : Storage shall be in accordance with the below conditions.

Storage temp. : 5 to 30°C

Storage humidity : 70%RH or less

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3.2 Treatment after open

(1) After open, please mount at the conditions of humidity 60%RH or less and temperature 5 to 25°C within 2 days.

(2) In case of long time storage after open, please mount at the conditions of humidity 70%RH or less and temperature 5 to 30°C within 2 weeks by using dry box or resealing with desiccant in moisture-proof sack by sealer.

3.3 Baking before mounting

In case that it could not carry out the above treatment, it is able to mount by baking treatment. However baking treatment shall be limited only 1 time.

Recomended conditions : 125°C, 16 to 24 hours

* Baking treatment can not carry out at the packaged condition. please carry out baking at the condition of mounting on PWB or getting on the metal tray.

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